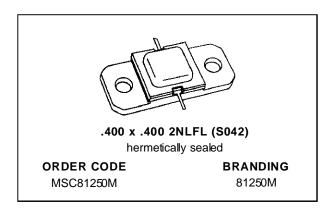


MSC81250M

RF & MICROWAVE TRANSISTORS AVIONICS APPLICATIONS

- REFRACTORY\GOLD METALLIZATION
- RUGGEDIZED VSWR 20:1
- INTERNAL INPUT/OUTPUT MATCHING
- LOW THERMAL RESISTANCE
- METAL/CERAMIC HERMETIC PACKAGE
- Pout = 250 W MIN. WITH 6.2 dB GAIN

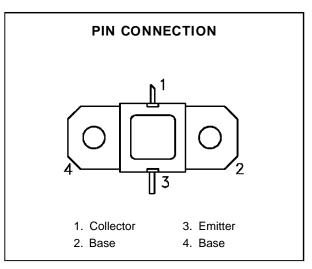


DESCRIPTION

The MSC81250M device is a high power pulsed transistor specifically designed for DME/TACAN avionics applications.

This device is capable of withstanding a minimum 20:1 load VSWR at any phase angle under full rated conditions. Low RF thermal resistance and semi automatic wire bonding techniques ensure high reliability and product consistency.

The MSC81250M is housed in the unique AMPAC™ package with internal input/output matching structures.



ABSOLUTE MAXIMUM RATINGS $(T_{case} = 25^{\circ}C)$

Symbol	Parameter	Value	Unit
Poiss	Power Dissipation* (T _C ≤ 80°C)	600	W
Ic	Device Current*	17.8	А
Vcc	Collector-Supply Voltage*	55	V
TJ	Junction Temperature (Pulsed RF Operation)	250	°C
T _{STG}	Storage Temperature	- 65 to +200	°C

THERMAL DATA

R _{TH(j-c)}	Junction-Case Thermal Resistance*	0.20	°C/W

^{*}Applies only to rated RF amplifier operation

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ELECTRICAL SPECIFICATIONS (T_{case} = 25°C)

STATIC

Symbol	Test Conditions	Value			11		
		Min.	Тур.	Max.	Unit		
ВУсво	I _C = 10mA	$I_E = 0mA$		65	_	_	V
BV _{EBO}	I _E = 1mA	$I_C = 0mA$		3.5	_		V
BV _{CER}	IC = 25mA	$R_{BE} = 10\Omega$		65	_	_	V
Ices	V _{CE} = 50V			_	_	25	mA
h _{FE}	V _{CE} = 5V	$I_C = 1A$		15	_	120	_

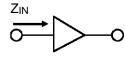
DYNAMIC

Symbol	Symbol Test Conditions		Value		
Symbol			Тур.	Max.	Unit
Pout	$f = 1025 - 1150 \text{ MHz}$ $P_{IN} = 60 \text{ W}$ $V_{CC} = 50 \text{ V}$	250	270		W
ης	$f = 1025 - 1150 \text{ MHz}$ $P_{IN} = 60 \text{ W}$ $V_{CC} = 50 \text{ V}$	40	38	_	%
G _P	$f = 1025 - 1150 \text{ MHz}$ $P_{IN} = 60 \text{ W}$ $V_{CC} = 50 \text{ V}$	6.2	6.5	_	dB

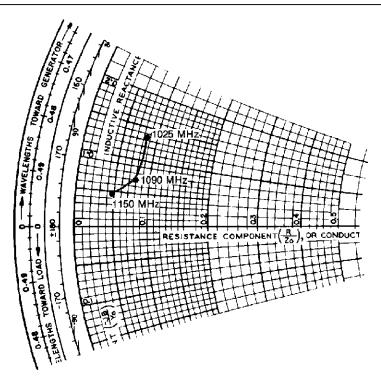
Note: Pulse Width = $10\mu Sec$ Duty Cycle = 1%

IMPEDANCE DATA

TYPICAL INPUT IMPEDANCE

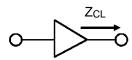


 $P_{IN} = 60 \text{ W}$ $V_{CC} = 50 \text{ V}$ Normalized to 50 ohms



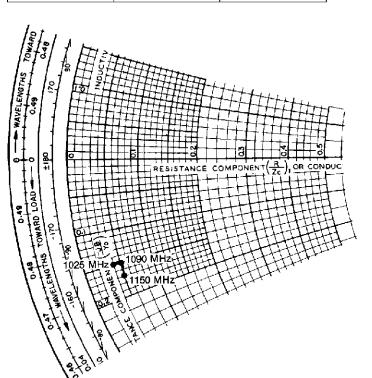
FREQ.	Z _{IN} (Ω)	Z _{CL} (Ω)
L = 1025 MHz	4.2 + j 6.7	2.0 – j 7.5
M = 1090 MHz	4.0 + j 3.5	2.5 – j 7.5
H = 1150 MHz	2.3 + j 2.3	2.5 – j 8.5

TYPICAL COLLECTOR LOAD IMPEDANCE

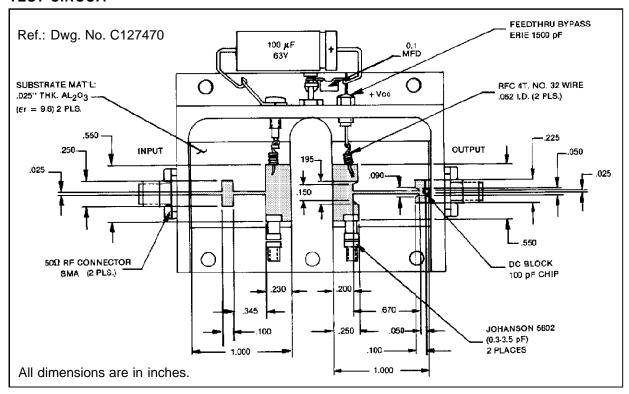


 $P_{IN} = 60 \text{ W}$ $V_{CC} = 50 \text{ V}$

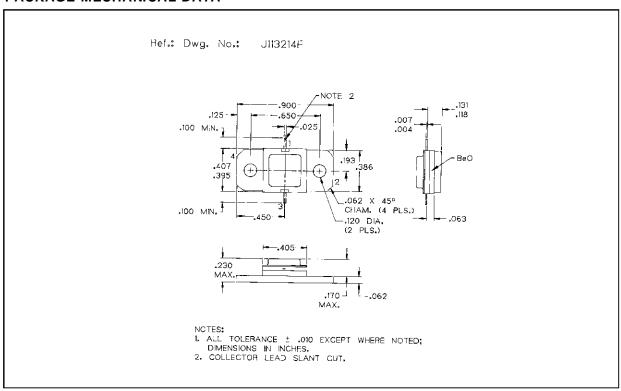
Normalized to 50 ohms



TEST CIRCUIT



PACKAGE MECHANICAL DATA



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